

## N-Channel 20-V (D-S) MOSFET

### PRODUCT SUMMARY

$V_{DS}$ (V)	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A) <sup>a</sup>	$Q_g$ (Typ.)
20	0.0186 at $V_{GS} = 10$ V	4.8	7.9 nC
	0.021 at $V_{GS} = 4.5$ V	4.8	
	0.025 at $V_{GS} = 2.5$ V	4.5	

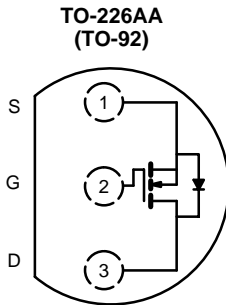
### FEATURES

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- New Thermally Enhanced PowerPAK<sup>®</sup> SC-70 Package
  - Small Footprint Area
  - Low On-Resistance
- 100 %  $R_g$  Tested

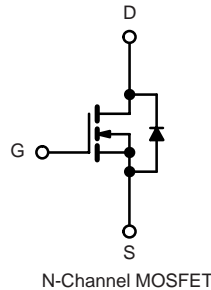

**RoHS**  
 COMPLIANT

### APPLICATIONS

- Load Switch



Top View



### ABSOLUTE MAXIMUM RATINGS $T_A = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	
Continuous Drain Current ( $T_J = 150^\circ\text{C}$ ) <sup>a</sup>	$T_C = 25^\circ\text{C}$	4.8 <sup>a</sup>	A
	$T_C = 70^\circ\text{C}$	4.5 <sup>a</sup>	
	$T_A = 25^\circ\text{C}$	4.8 <sup>a, b, c</sup>	
	$T_A = 70^\circ\text{C}$	4.5 <sup>a, b, c</sup>	
Pulsed Drain Current	$I_{DM}$	20	
Continuous Source-Drain Diode Current	$T_C = 25^\circ\text{C}$	4.5 <sup>a</sup>	
	$T_A = 25^\circ\text{C}$	2.9 <sup>b, c</sup>	
Maximum Power Dissipation	$T_C = 25^\circ\text{C}$	1.9	W
	$T_C = 70^\circ\text{C}$	1.2	
	$T_A = 25^\circ\text{C}$	0.5 <sup>b, c</sup>	
	$T_A = 70^\circ\text{C}$	0.2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to 150	$^\circ\text{C}$
Soldering Recommendations (Peak Temperature)		260	

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient	$R_{thJA}$	28	36	$^\circ\text{C/W}$
Maximum Junction-to-Case (Drain)	$R_{thJC}$	5.3	6.5	

Notes:

a. Package limited

b. Surface Mounted on 1" x 1" FR4 board.

c.  $t = 5$  s.

SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	20			V	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA		25		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	ΔV <sub>GS(th)</sub> /T <sub>J</sub>			- 3.7			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	0.6		1.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 12 V			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μA	
		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≤ 5 V, V <sub>GS</sub> = 4.5 V		20		A	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.8 A		0.0186		Ω	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4.8 A		0.021			
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 4.8 A		0.025			
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4.8 A		20		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1020		pF	
Output Capacitance	C <sub>oss</sub>			160			
Reverse Transfer Capacitance	C <sub>rss</sub>			70			
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.8 A		17.5	27	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4.8 A		7.9	16		
Gate-Drain Charge	Q <sub>gd</sub>			2.1			
Gate Resistance	R <sub>g</sub>			1.1			
Turn-On Delay Time	t <sub>d(on)</sub>	f = 1 MHz	0.6	3	6	Ω	
Rise Time	t <sub>r</sub>		V <sub>DD</sub> = 10 V, R <sub>L</sub> = 1.3 Ω I <sub>D</sub> ≅ 3.9 A, V <sub>GEN</sub> = 4.5 V, R <sub>g</sub> = 1 Ω		12	18	ns
Turn-Off Delay Time	t <sub>d(off)</sub>				11	17	
Fall Time	t <sub>f</sub>				27	41	
Turn-On Delay Time	t <sub>d(on)</sub>			11	17		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, R <sub>L</sub> = 1.3 Ω I <sub>D</sub> ≅ 3.9 A, V <sub>GEN</sub> = 10 V, R <sub>g</sub> = 1 Ω		7	14		
Rise Time	t <sub>r</sub>			10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>			20	30		
Fall Time	t <sub>f</sub>			8	16		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			4.5 <sup>c</sup>	A	
Pulse Diode Forward Current	I <sub>SM</sub>				20		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 3.9 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 7.9 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		16	24	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			6	12	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			7		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			8			

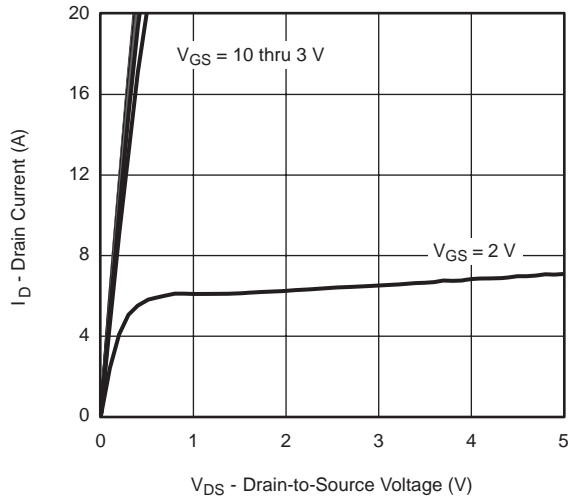
Notes:

a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .

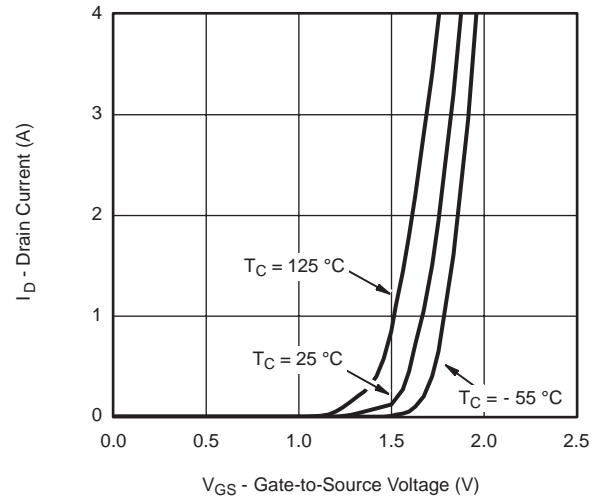
b. Guaranteed by design, not subject to production testing.

c. Package Limited

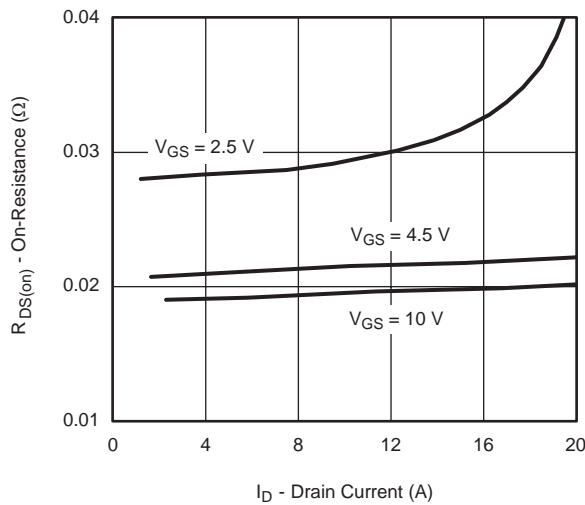
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



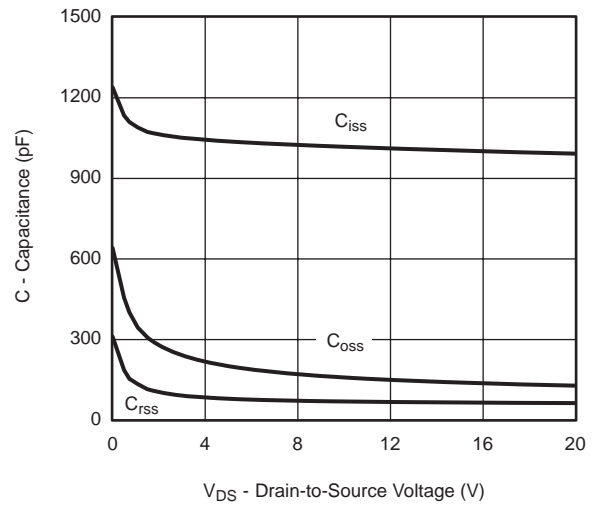
**Output Characteristics**



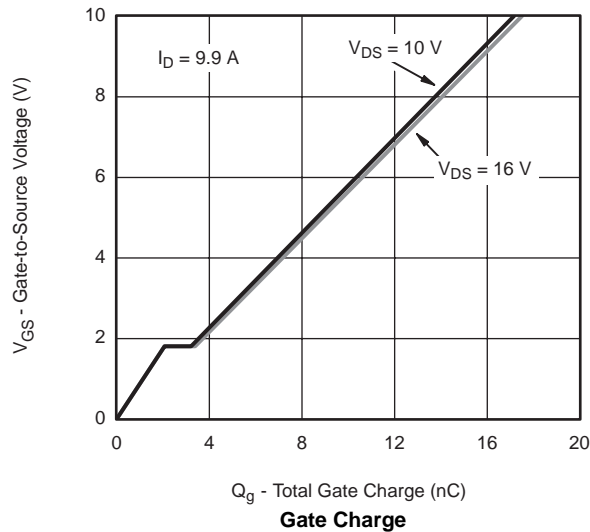
**Transfer Characteristics**



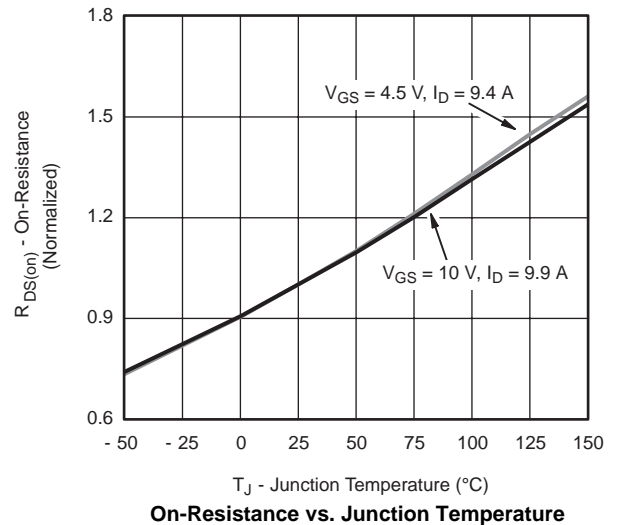
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

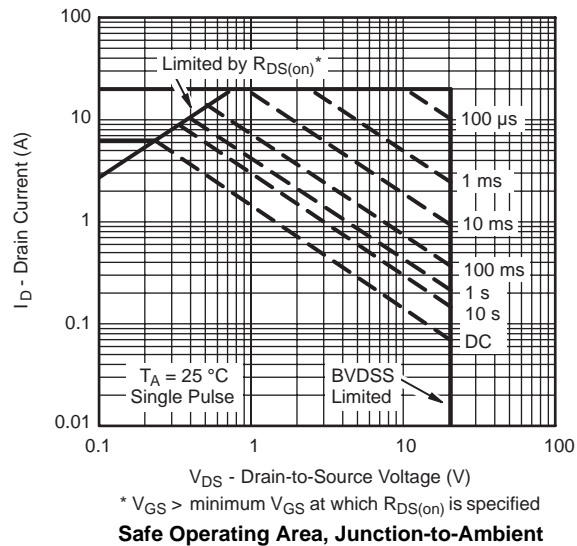
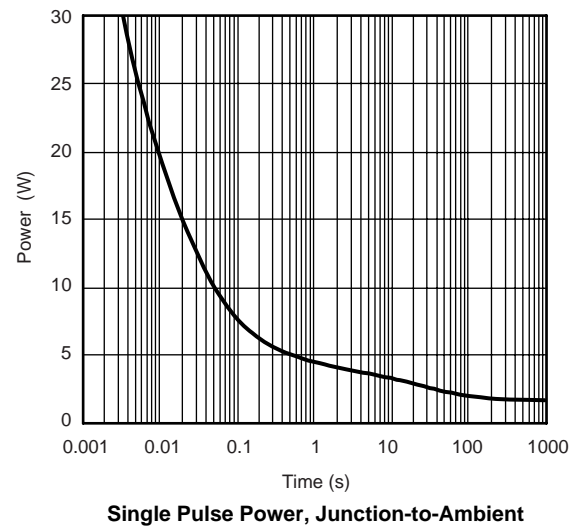
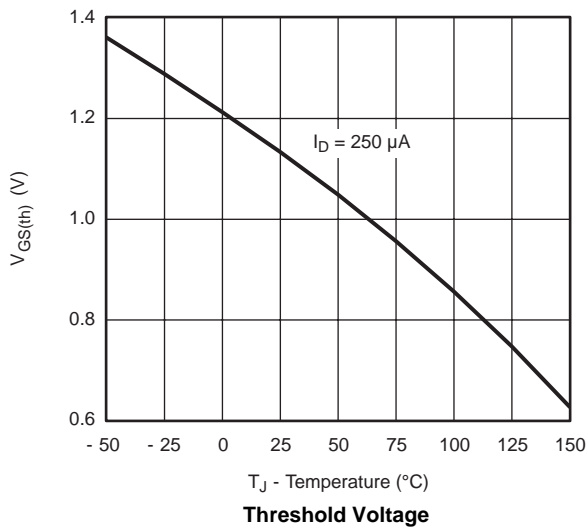
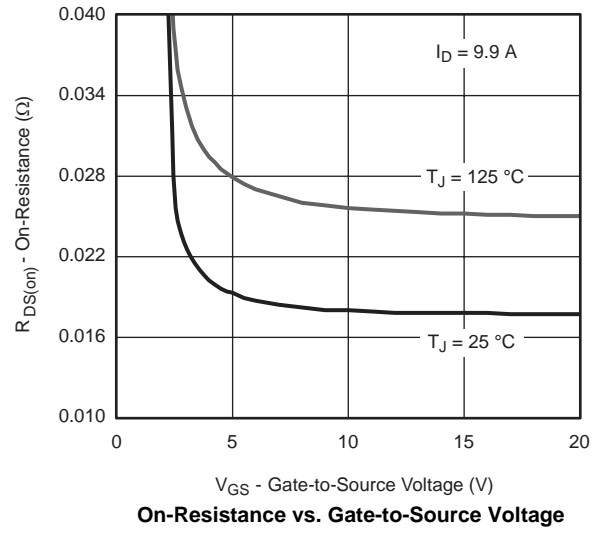
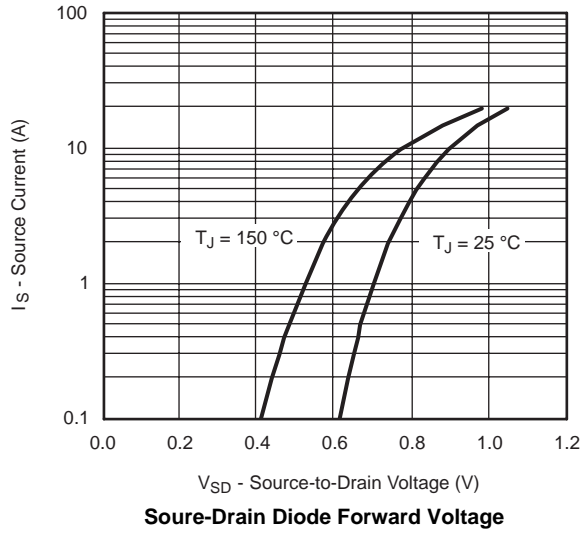


**Gate Charge**

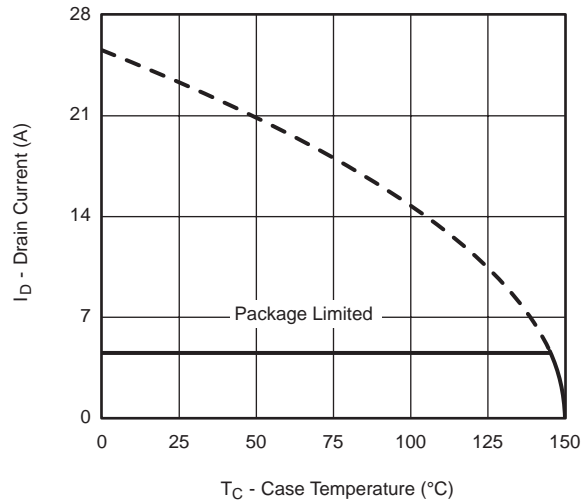
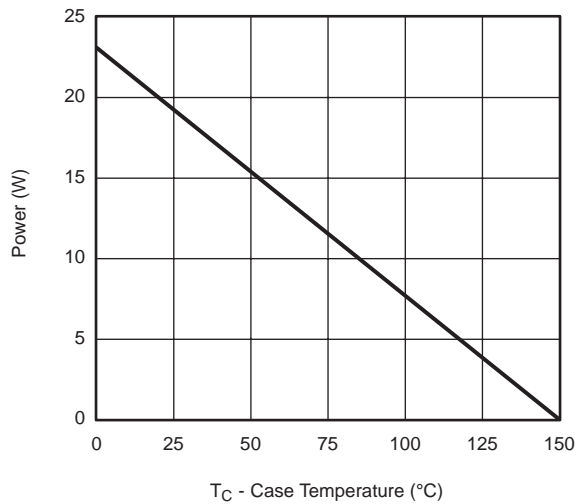
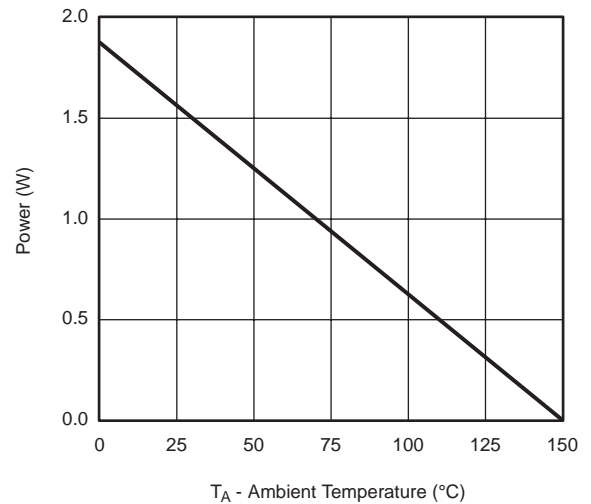


**On-Resistance vs. Junction Temperature**

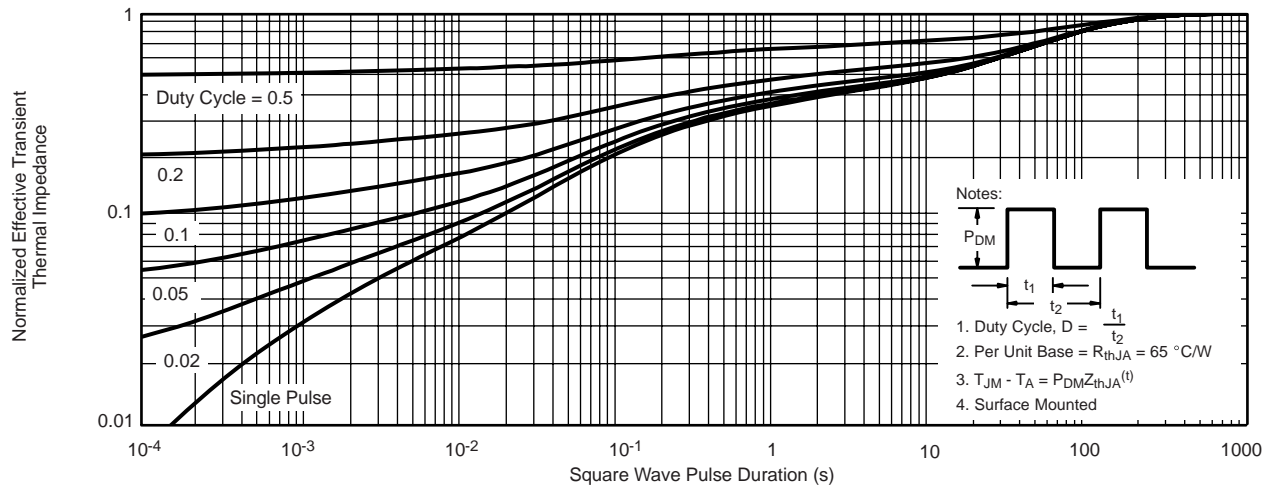
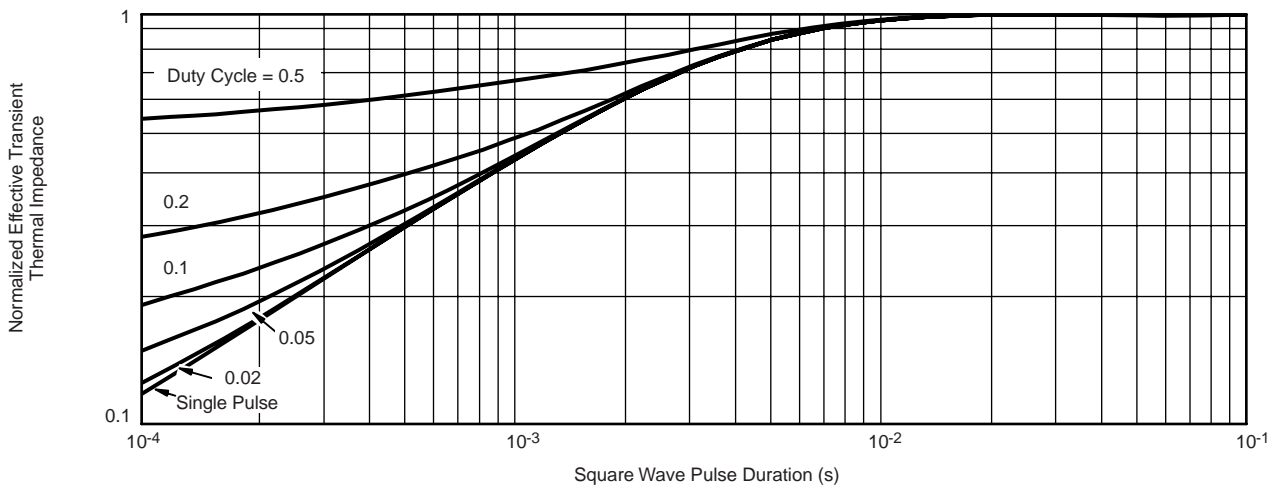
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

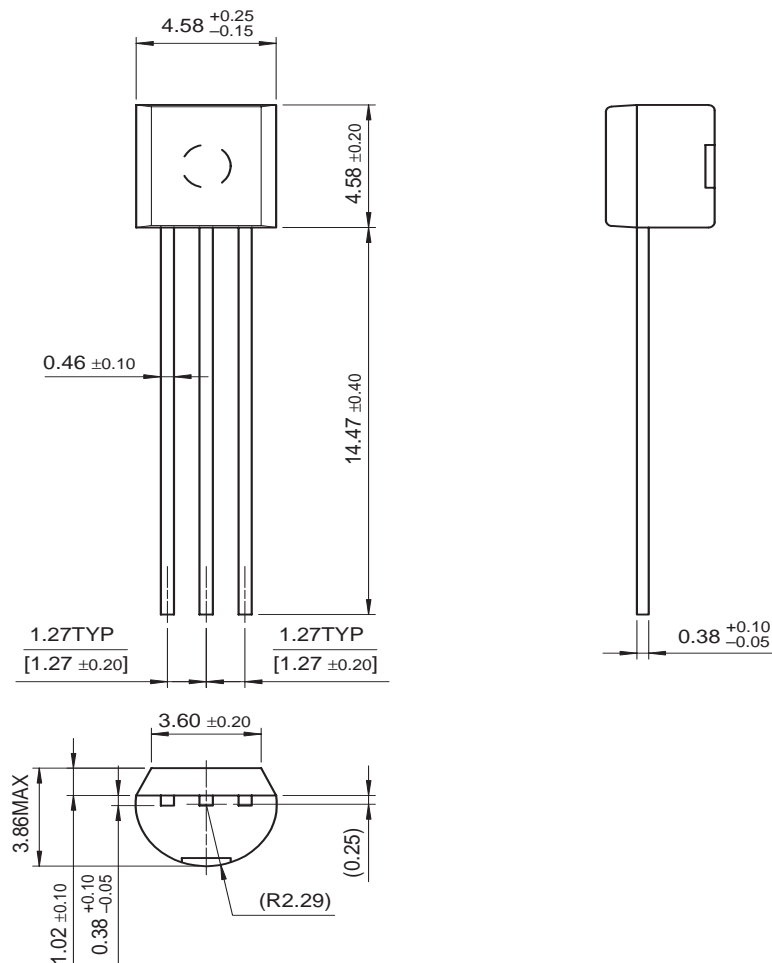
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

**Current Derating\***

**Power, Junction-to-Case**

**Power, Junction-to-Ambient**

\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

**Normalized Thermal Transient Impedance, Junction-to-Ambient**

**Normalized Thermal Transient Impedance, Junction-to-Case**

Mechanical Dimensions

TO-92



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